# MOSFET - N-Channel, POWERTRENCH®

150 V, 169 A, 6.3 mΩ

# FDBL86210-F085

#### **Features**

- Typical  $r_{DS(on)} = 5 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 80 \text{ A}$
- Typical  $Q_{g(tot)} = 70 \text{ nC}$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 80 \text{ A}$
- UIS Capability
- AEC-Q101 Qualified and PPAP Capable
- This Device is Pb-Free and are RoHS Compliant

## **Applications**

- Automotive Engine Control
- PowerTrain Management
- Solenoid and Motor Drivers
- Integrated Starter/Alternator
- Primary Switch for 12 V Systems

#### MOSFET MAXIMUM RATINGS (T<sub>.1</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
$V_{DSS}$	Drain to Source Voltage	150	V
V <sub>GS</sub>	Gate to Source Voltage	±20	V
I <sub>D</sub>	Drain Current – Continuous (V <sub>GS</sub> = 10), T <sub>C</sub> = 25°C (Note 1)	169	Α
	Pulsed Drain Current, T <sub>C</sub> = 25°C	See Figure 4	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 2)	502	mJ
P <sub>D</sub>	Power Dissipation	500	W
	Derate Above 25°C	3.3	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55 to +175	°C
$R_{ heta JC}$	Thermal Resistance Junction to Case	0.3	°C/W
$R_{ heta JA}$	Maximum Thermal Resistance Junction to Ambient (Note 3)	43	°C/W

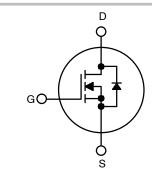
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Current is limited by silicon.
- 2. Starting  $T_J = 25^{\circ}C$ , L = 0.24 mH,  $I_{AS} = 64$  A,  $V_{DD} = 100$  V during inductor charging and  $V_{DD} = 0$  V during time in avalanche.
- 3.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design, while  $R_{\theta JA}$ is determined by the user's board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2oz copper.



#### ON Semiconductor®

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N-Channel



H-PSOF8L CASE 100CU

#### **MARKING DIAGRAM**



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code &K = Lot Code

FDBL86210 = Specific Device Code

#### **ORDERING INFORMATION**

	Device	Top Mark	Package	Shipping <sup>†</sup>
- 1	FDBL86210 -F085	FDBL86210	H-PSOF8L	2000 Units/ Tape&Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

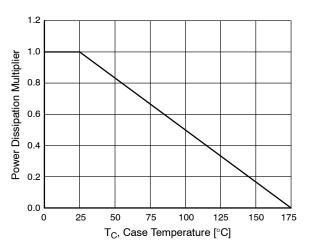
# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
OFF CHARAC	CTERISTICS						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V		150	-	-	V
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> = 150 V,	T <sub>J</sub> = 25°C	-	-	1	μΑ
		V <sub>GS</sub> = 0 V	T <sub>J</sub> = 175°C (Note 4)	-	-	1	mA
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V		-	-	±100	nA
ON CHARACT	TERISTICS						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D =$	: 250 μA	2.0	2.8	4.0	V
r <sub>DS(on)</sub>	Drain to Source On Resistance	I <sub>D</sub> = 80 A, T <sub>J</sub> = 25°C		-	5	6.3	mΩ
		V <sub>GS</sub> = 10 V	T <sub>J</sub> = 175°C (Note 4)	_	14	17.5	mΩ
DYNAMIC CH	ARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 75 V, V <sub>GS</sub>	<sub>S</sub> = 0 V, f = 1 MHz	_	5805	-	pF
C <sub>oss</sub>	Output Capacitance	f = 1 MHz		_	536	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			_	16	-	pF
$R_{g}$	Gate Resistance			_	2.2	-	Ω
Q <sub>g(ToT)</sub>	Total Gate Charge at 10 V	$V_{GS} = 0 \text{ to } 10 \text{ V}$ $V_{DD} = 75 \text{ V},$ $I_D = 80 \text{ A}$		_	70	90	nC
Q <sub>g(th)</sub>	Threshold Gate Charge			_	10.5	13	nC
$Q_{gs}$	Gate to Source Gate Charge	V <sub>DD</sub> = 75 V, I <sub>D</sub> = 80 A		-	32.5	-	nC
$Q_gd$	Gate to Drain "Miller" Charge			-	10	-	nC
SWITCHING C	CHARACTERISTICS						
t <sub>on</sub>	Turn-On Time	V <sub>DD</sub> = 75 V, I <sub>D</sub> =	= 80 A,	-	-	80	ns
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{GS} = 10 \text{ V}, R_{G}$	EN = ρ 75	-	39	-	ns
t <sub>r</sub>	Rise Time	1		-	30	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			-	70	-	ns
t <sub>f</sub>	Fall Time			-	23	-	ns
t <sub>off</sub>	Turn-Off Time			_	-	130	ns
DRAIN-SOUF	RCE DIODE CHARACTERISTIC						
$V_{SD}$	Source to Drain Diode Voltage	I <sub>SD</sub> = 80 A, V <sub>GS</sub> = 0 V		-	-	1.25	V
		I <sub>SD</sub> = 40 A, V <sub>GS</sub>	; = 0 V	-	_	1.2	V
T <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 80 A, dI <sub>SD</sub> /d	dt = 100 A/μs,	-	108	125	ns
$Q_{rr}$	Reverse Recovery Charge	V <sub>DD</sub> = 120 V		-	323	467	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. The maximum value is specified by design at T<sub>J</sub> = 175°C. Product is not tested to this condition in production.

#### **TYPICAL CHARACTERISTICS**



200 160 120 80 40 25 50 75 100 125 150 175 200 T<sub>C</sub>, Case Temperature [°C]

Figure 1. Normalized Power Dissipation vs. Case Temperature

Figure 2. Maximum Continuous Drain Current vs. Case Temperature

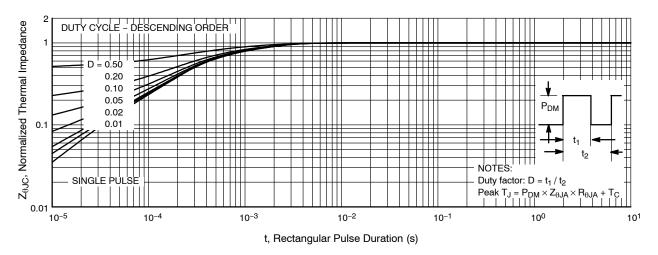


Figure 3. Normalized Maximum Transient Thermal Impedance

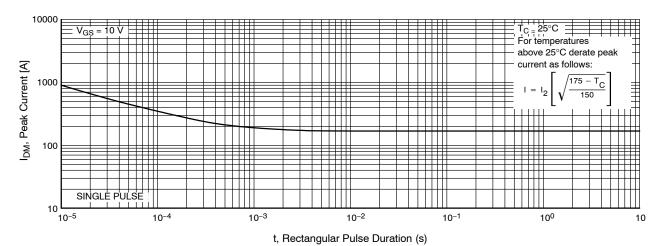


Figure 4. Peak Current Capability

#### TYPICAL CHARACTERISTICS (continued)

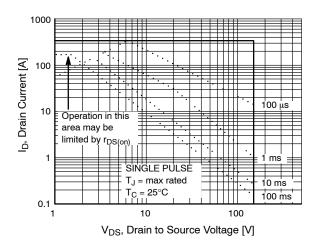


Figure 5. Forward Bias Safe Operating Area

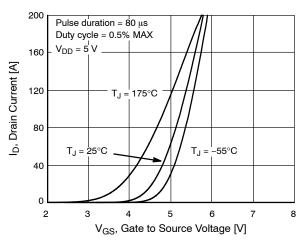


Figure 7. Transfer Characteristics

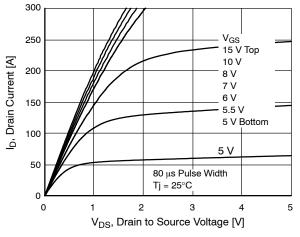
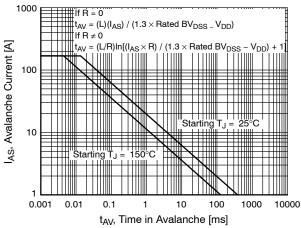


Figure 9. Saturation Characteristics



NOTE: Refer to ON Semiconductor Application Notes AN7514 and AN7515.

Figure 6. Unclamped Inductive Switching Capability

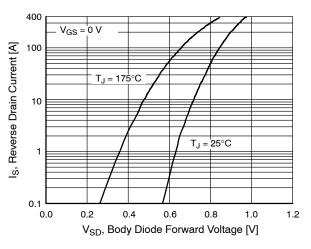


Figure 8. Forward Diode Characteristics

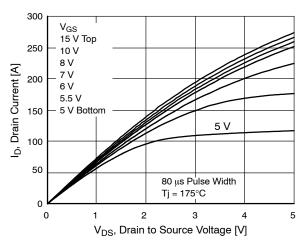


Figure 10. Saturation Characteristics

## TYPICAL CHARACTERISTICS (continued)

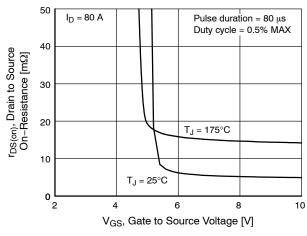


Figure 11. R<sub>DSON</sub> vs. Gate Voltage

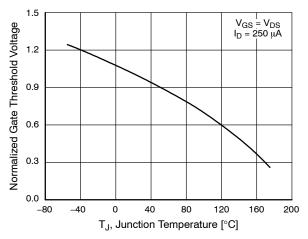


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

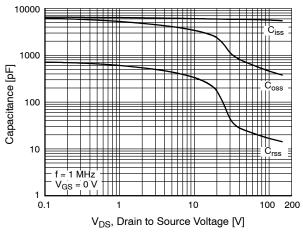


Figure 15. Capacitance vs. Drain to Source Voltage

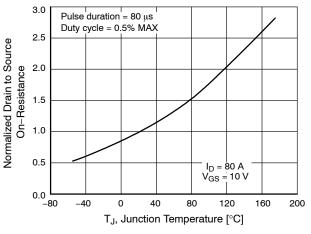


Figure 12. Normalized R<sub>DSON</sub> vs. Junction Temperature

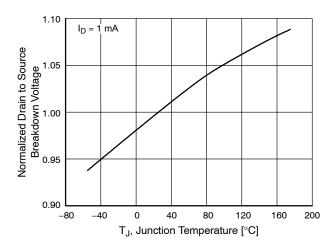


Figure 14. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

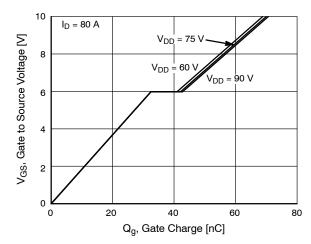


Figure 16. Gate Charge vs. Gate to Source Voltage

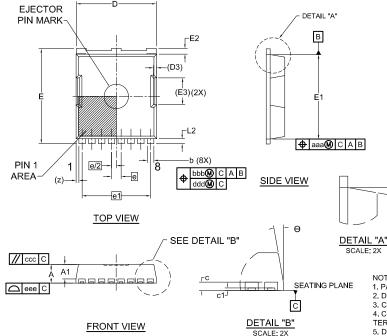
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#### H-PSOF8L 11.68x9.80 CASE 100CU **ISSUE B**

#### **DATE 20 MAY 2022**



5.10--4 45-2.95 8.10 4.99 2.04 2 90 13,28 1.46 0.60 0.86 2.80 1.20 0.80 Α

10.20

#### LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

#### NOTES:

- 1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE A.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009. 3. CONTROLLING DIMENSION: MILLIMETERS.
- 4. COPLANARITY APPLIES TO THE EXPOSED WELL AS THE TERMINALS.
- 5. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 6. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

AD1	Ф ааа (М С А В
1 8 1 8 1 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	11 +
——————————————————————————————————————	GENERIC MARKING DIAGRAM*  AYWWZZ  XXXXXXXX  XXXXXXXX

Α

WW

ZΖ

DIM	MILLIMETERS			
DIW	MIN.	NOM.	MAX.	
Α	2.20	2.30	2.40	
A1	1.70	1.80	1.90	
b	0.70	0.80	0.90	
b1		8.00 REF	:	
С	0.40	0.50	0.60	
c1	0.10			
D	9.70	9.80	9.90	
D1	9.80	9.90	10.00	
D2	4.73 BSC			
D3		0.40 REF	=	
D4	;	3.75 BSC	;	
D5		1.20		
D6	7.40	7.50	7.60	
D7		3.30 REF		
Е	11.58	11.68	11.78	
E1	10.28	10.38	10.48	
E2	0.60	0.70	0.80	
E3	3.30 REF			
E4		2.60		
E5		3.30		

DIM	MILLIMETERS			
DIW	MIN.	NOM.	MAX.	
E6	- 0.65			
E7		7.15 REF	:	
E8	6.55	6.65	6.75	
E9		5.89 BSC	)	
E10		5.19 BSC	)	
E11		0.10 REF	:	
е		1.20 BSC	;	
e/2		0.60 BSC	;	
e1		8.40 BSC	)	
K	2.43	2.53	2.63	
L	1.90	2.00	2.10	
L2	0.50	0.60	0.70	
z		0.35 REF	•	
θ	0°		12°	
aaa	0.20			
bbb	0.25			
ccc	0.20			
ddd	0.20			
eee	0.10			

= Assembly Location = Year = Work Week = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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XXXX = Specific Device Code

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